# MOSFET, N-Channel, Shielded Gate, POWERTRENCH<sup>®</sup>

# 100 V, 50 A, 10.6 m $\Omega$

# **General Description**

This N-Channel POWETRENCH<sup>®</sup> MOSFET is produced using ON Semiconductor's advanced POWERTRENCH<sup>®</sup> process that incorporates Shielded Gate technology. This process has been optimized to minimize on-state resistance and yet maintain superior switching performance with best in class soft body diode.

### Features

- Shielded Gate MOSFET Technology
- Max  $r_{DS(on)} = 10.6 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 15 \text{ A}$
- Max  $r_{DS(on)} = 15.9 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 12 \text{ A}$
- 50% Lower Qrr than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant

### Applications

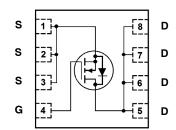
- Primary DC-DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive



# **ON Semiconductor®**

www.onsemi.com

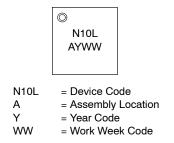
# **ELECTRICAL CONNECTION**



N-Channel MOSFET







### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

# **MOSFET MAXIMUM RATINGS** (T<sub>A</sub> = $25^{\circ}$ C unless otherwise noted)

Symbol	Parameter				Ratings	Unit
V <sub>DS</sub>	Drain to Source	Drain to Source Voltage				V
V <sub>GS</sub>	Gate to Source V	/oltage			±20	V
Ι <sub>D</sub>	Drain Current	-Continuous	$T_{C} = 25^{\circ}C$	(Note 5)	50	А
		-Continuous	$T_{C} = 100^{\circ}C$	(Note 5)	32	
		-Continuous	$T_A = 25^{\circ}C$	(Note 1a)	10.7	
		-Pulsed		(Note 4)	250	
E <sub>AS</sub>	Single Pulse Ava	lanche Energy		(Note 3)	73	mJ
PD	Power Dissipatio	n	$T_{C} = 25^{\circ}C$		52	W
	Power Dissipatio	n	$T_A = 25^{\circ}C$	(Note 1a)	2.3	
T <sub>J</sub> , T <sub>STG</sub>	Operating and St	orage Junction Tempe	rature Range		–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### **THERMAL CHARACTERISTICS**

Symbol	Parameter	Ratings	Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	2.4	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

# PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package	Reel Size	Tape Width	Quantity
NTTFS010N10MCL	N10L	WDFN8 (3.3x3.3)	7"	12 mm	1500 Units

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
OFF CHARACT	ERISTICS					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, V_{GS} = 0 \ V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 µA, referenced to 25°C		64		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ = 80 V, $V_{GS}$ = 0 V			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS}$ = ±20 V, $V_{DS}$ = 0 V			100	nA

### **ON CHARACTERISTICS**

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 85 \ \mu A$	1.0	1.5	3.0	V
$\frac{\Delta V_{\text{GS(th)}}}{\Delta T_{\text{J}}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 85 \ \mu A$ , referenced to $25^{\circ}C$		-5.3		mV/°C
r <sub>DS(on)</sub>	Static Drain to Source On	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A		9.1	10.6	mΩ
	Resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 12 A		13.5	15.9	1
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A, T <sub>J</sub> = 125°C		15.3	17.8	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 15 A		54		S

#### **DYNAMIC CHARACTERISTICS**

C <sub>ISS</sub>	Input Capacitance	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V},$		1530	2150	pF
C <sub>OSS</sub>	Output Capacitance	f = 1 MHz		625	875	
C <sub>RSS</sub>	Reverse Transfer Capacitance			10	18	
R <sub>G</sub>	Gate Resistance		0.1	1.1	2.1	Ω

### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condit	ions	Min	Тур	Мах	Units
SWITCHING CH	IARACTERISTICS						
t <sub>d(ON)</sub>	Turn – On Delay Time		V <sub>DD</sub> = 50 V, I <sub>D</sub> = 15 A,			19	ns
t <sub>rd(ON)</sub>	Rise Time	V <sub>GS</sub> = 10 V, R <sub>GEN</sub> =	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		3	10	
t <sub>d(OFF)</sub>	Turn – Off Delay Time	]			28	45	
t <sub>f</sub>	Fall Time				5	10	
Qg	Total Gate Charge	$V_{GS} = 0V$ to 10 V			22	30	nC
Qg	Total Gate Charge	$V_{GS}$ = 0V to 4.5 V			10		
Q <sub>gs</sub>	Gate to Source Charge		V <sub>DD</sub> = 50 V		4		
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	I <sub>D</sub> = 15 A			3		
Q <sub>oss</sub>	Output Charge	V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 0 V			41		nC
Q <sub>sync</sub>	Total Gate Charge Sync	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 0 t	o 10 V		19		

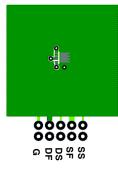
#### **DRAIN-SOURCE DIODE CHARACTERISTICS**

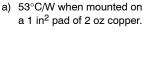
V <sub>SD</sub>	Source to Drain Diode Forward	$V_{GS} = 0 V, I_S = 2 A$ (Note 2)	0.7	1.2	V
	Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 15 A (Note 2)	0.8	1.3	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 8 A, di/dt = 300 A/µs	22	36	ns
Q <sub>rr</sub>	Reverse Recovery Charge		35	56	nC
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 8 A, di/dt = 1000 A/μs	17	30	ns
Q <sub>rr</sub>	Reverse Recovery Charge		79	126	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### NOTES:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material.  $R_{\theta CA}$  is determined by the user's board design.





G DE SE SE

b) 125°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3.  $E_{AS}$  of 73 mJ is based on starting  $T_J$  = 25°C; L = 3 mH,  $I_{AS}$  = 7 A,  $V_{DD}$  = 100 V,  $V_{GS}$  = 10 V. 100% test at L = 0.5 mH,  $I_{AS}$  = 13 A.
- Pulsed I<sub>D</sub> please refer to Figure 11 SOA graph for more details.
  Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.



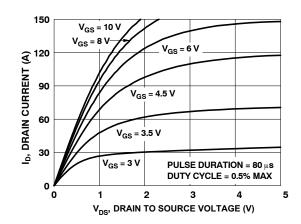


Figure 1. On Region Characteristics

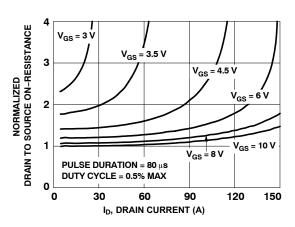
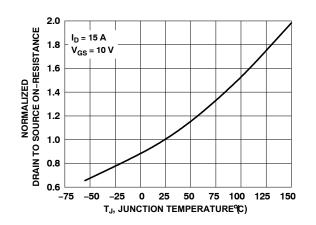


Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage





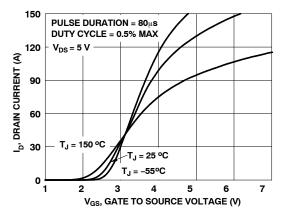


Figure 5. Transfer Characteristics

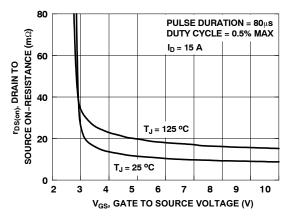


Figure 4. On-Resistance vs. Gate to Source Voltage

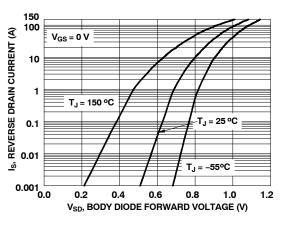


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

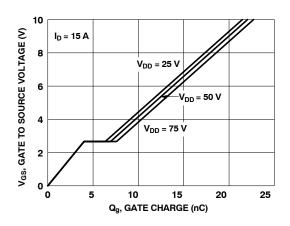
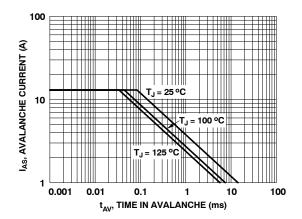


Figure 7. Gate Charge Characteristics





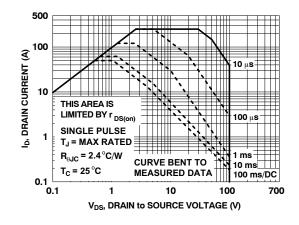


Figure 11. Forward Bias Safe Operating Area

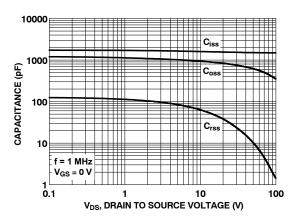


Figure 8. Capacitance vs. Drain to Source Voltage

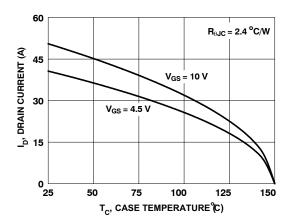


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

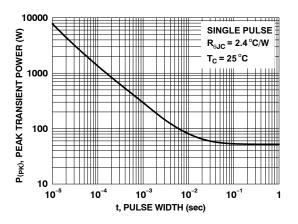


Figure 12. Single Pulse Maximum Power Dissipation

## TYPICAL CHARACTERISTICS (continued)

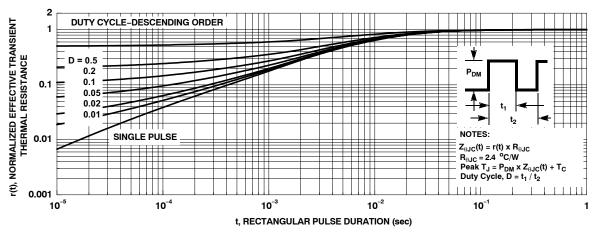
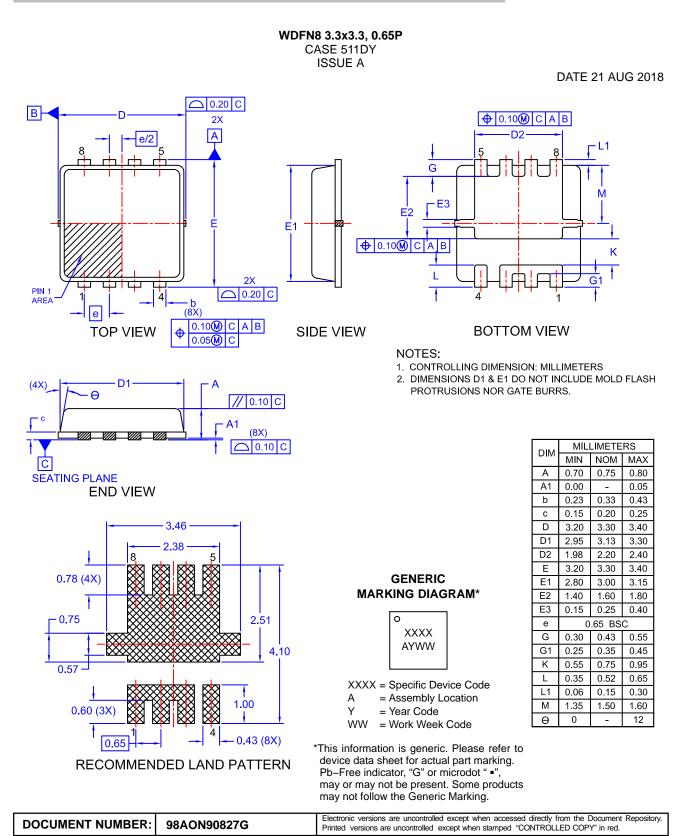


Figure 13. Junction-to-Case Transient Thermal Response Curve

POWERTRENCH is registered trademark of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries.





DESCRIPTION:	WDFN8 3.3x3.3, 0.65P		PAGE 1 OF 1
		stries, LLC dba ON Semiconductor or its subsidiaries in the United States y products herein. ON Semiconductor makes no warranty, representation	

the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor date sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use a a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor houteds for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

#### TECHNICAL SUPPORT

ON Semiconductor Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800–282–9855 Toll Free USA/Canada Phone: 011 421 33 790 2910 Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative